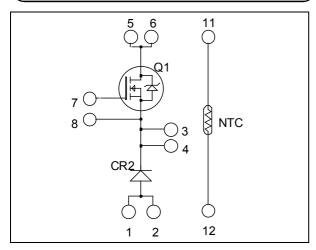
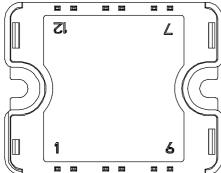


Buck chopper Super Junction MOSFET SiC chopper diode





Pins 1/2; 3/4; 5/6 must be shorted together

$$\begin{split} V_{DSS} &= 900V \\ R_{DSon} &= 60 m\Omega \text{ max } @ \text{Tj} = 25^{\circ}\text{C} \\ I_D &= 59\text{A} @ \text{Tc} = 25^{\circ}\text{C} \end{split}$$

Application

- AC and DC motor control
- Switched Mode Power Supplies

Features

COOLMOS

Power Semiconductors

- Ultra low R_{DSon}
- Low Miller capacitance
- Ultra low gate charge
- Avalanche energy rated
- Very rugged

• CR1 SiC Schottky Diode

- Zero reverse recovery
- Zero forward recovery
- Temperature Independent switching behavior
- Positive temperature coefficient on VF
- Very low stray inductance
- Internal thermistor for temperature monitoring
- High level of integration

Benefits

- Outstanding performance at high frequency operation
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Solderable terminals both for power and signal for easy PCB mounting
- Low profile
- RoHS Compliant

Absolute maximum ratings

Symbol	Parameter		Max ratings	Unit
$V_{ m DSS}$	Drain - Source Breakdown Voltage		900	V
Ţ	Continuous Drain Current	$T_c = 25$ °C	59	
I_D	T Continuous Diani Current	$T_c = 80$ °C	44	Α
I_{DM}	Pulsed Drain current		150	
V_{GS}	Gate - Source Voltage		±20	V
R _{DSon}	Drain - Source ON Resistance		60	mΩ
P_{D}	Maximum Power Dissipation	$T_c = 25^{\circ}C$	462	W
I_{AR}	Avalanche current (repetitive and non repetitive)		8.8	Α
E_{AR}	Repetitive Avalanche Energy		2.9	- mJ
E_{AS}	Single Pulse Avalanche Energy		1940	1113

CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed. See application note APT0502 on www.microsemi.com

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All ratings @ $T_j = 25$ °C unless otherwise specified

Electrical Characteristics

	Symbol	Characteristic	Test Conditions	Min	Тур	Max	Unit
I_{DSS}	Zero Gate Voltage Drain Current	$V_{GS} = 0V, V_{DS} = 900V$ $T_j = 25^{\circ}C$			200	^	
		$V_{GS} = 0V, V_{DS} = 900V$ $T_j = 125^{\circ}C$		1000		μΑ	
	R _{DS(on)}	Drain – Source on Resistance	$V_{GS} = 10V, I_D = 52A$		50	60	mΩ
	V _{GS(th)}	Gate Threshold Voltage	$V_{GS} = V_{DS}$, $I_D = 6mA$	2.5	3	3.5	V
	I_{GSS}	Gate – Source Leakage Current	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$			200	nA

Dynamic Characteristics

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
C_{iss}	Input Capacitance	$V_{GS} = 0V ; V_{DS} = 100V$		13.6		nF
C_{oss}	Output Capacitance	f = 1MHz		0.66		111
Q_{g}	Total gate Charge	$V_{GS} = 10V$		540		
Q_{gs}	Gate – Source Charge	$V_{Bus} = 400V$		64		nC
Q_{gd}	Gate – Drain Charge	$I_{D} = 52A$		230		
$T_{d(on)}$	Turn-on Delay Time	Inductive Switching (125°C)		70		ns
$T_{\rm r}$	Rise Time	$V_{GS} = 10V$		20		
$T_{d(off)}$	Turn-off Delay Time	$V_{\text{Bus}} = 600V$ $I_{\text{D}} = 52A$		400		
T_{f}	Fall Time	$R_G = 3.8\Omega$		25		
Eon	Turn-on Switching Energy	Inductive switching @ 25°C		1.8		m I
E_{off}	Turn-off Switching Energy	$V_{GS} = 10V ; V_{Bus} = 600V$ $I_D = 52A ; R_G = 3.8\Omega$		1.5		mJ
Eon	Turn-on Switching Energy	Inductive switching @ 125°C		2.52		т
E_{off}	Turn-off Switching Energy	$V_{GS} = 10V ; V_{Bus} = 600V$ $I_D = 52A ; R_G = 3.8\Omega$		1.7		mJ

CR2 SiC diode ratings and characteristics

Symbol	Characteristic	Test Condition	Min	Typ	Max	Unit	
V_{RRM}	Maximum Peak Repetitive Reverse Voltage			1200			V
I_{RM}	Maximum Reverse Leakage Current	$V_R=1200V$ $T_j = 25^{\circ}C$ $T_j = 175^{\circ}C$	$T_j = 25^{\circ}C$		96	600	μA
1 _{RM}			v _R -1200 v	Waxiiiuiii Reveise Leakage Cuiteit V _R -1200 V	$T_{j} = 175^{\circ}C$		168
I_F	DC Forward Current	$Tc = 100^{\circ}C$			30		A
W	Diode Forward Voltage	$I_{\rm p} = 30\Delta$	$T_i = 25^{\circ}C$		1.6	1.8	V
V_{F}			$T_j = 175$ °C		2.3	3	V
Qc	Total Capacitive Charge	$I_F = 30A, V_R = di/dt = 1000A/\mu$		120		nC	
C	Total Capacitance	$f = 1MHz, V_R =$	= 200V		288		mE.
С		$f = 1MHz, V_R = 400V$			207		pF

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Thermal and package characteristics

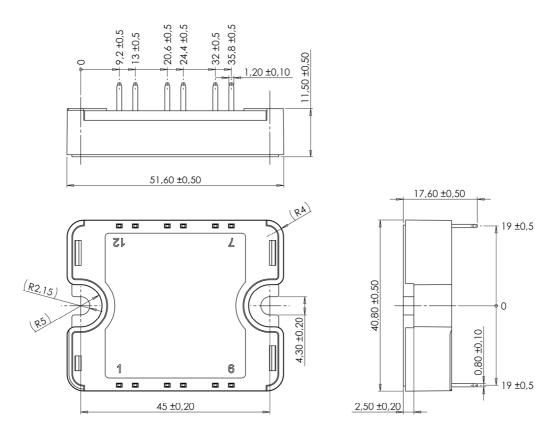
Symbol	Characteristic			Min	Тур	Max	Unit	
R_{thJC}	Junction to Case Thermal Resistance	(CoolN	1OS			0.27	°C/W
T _{th} JC			SiC D	iode			0.63	C/ W
V_{ISOL}	RMS Isolation Voltage, any terminal to case t =1 min, 50/60Hz			4000			V	
T_{J}	Operating junction temperature range			-40		150		
T_{STG}	Storage Temperature Range			-40		125	°C	
$T_{\rm C}$	Operating Case Temperature			-40		100		
Torque	Mounting torque	To heatsi	nk	M4	2		3	N.m
Wt	Package Weight					80	g	

Temperature sensor NTC (see application note APT0406 on www.microsemi.com for more information).

Symbol	Characteristic		Min	Typ	Max	Unit
R ₂₅	Resistance @ 25°C			50		kΩ
$\Delta R_{25}/R_{25}$				5		%
${ m B}_{25/85}$	$T_{25} = 298.15 \text{ K}$			3952		K
$\Delta \mathrm{B/B}$		T _C =100°C		4		%

$$R_{T} = \frac{R_{2\text{S}}}{\exp \left[B_{2\text{S}/8\text{S}} \left(\frac{1}{T_{2\text{S}}} - \frac{1}{T} \right) \right]} \quad \text{T: Thermistor temperature} \\ R_{T}: \text{ Thermistor value at T}$$

SP1 Package outline (dimensions in mm)

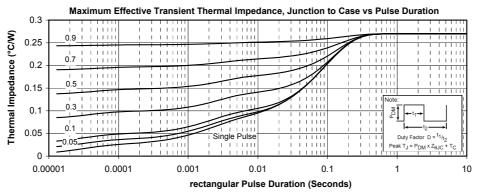


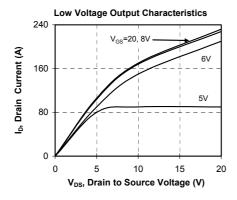
See application note 1904 - Mounting Instructions for SP1 Power Modules on www.microsemi.com

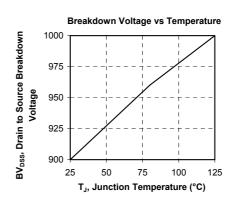
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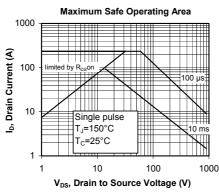


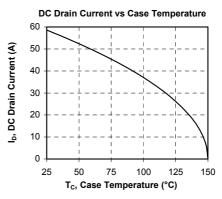
Typical CoolMOS Performance Curve

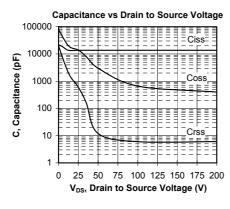


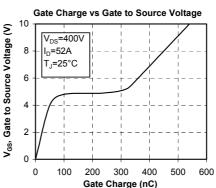






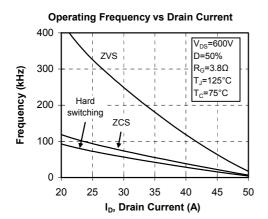


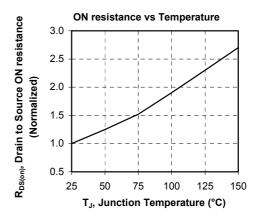


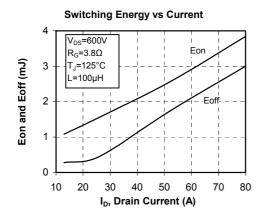


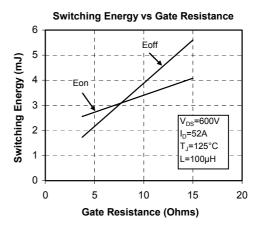
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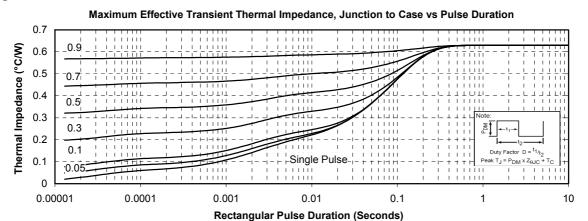


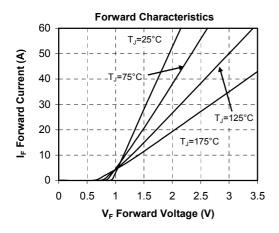


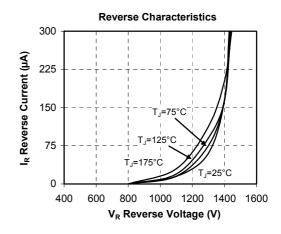


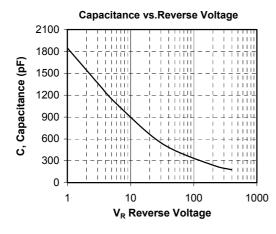


Typical CR2 SiC Diode Performance Curve









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